

# signetics

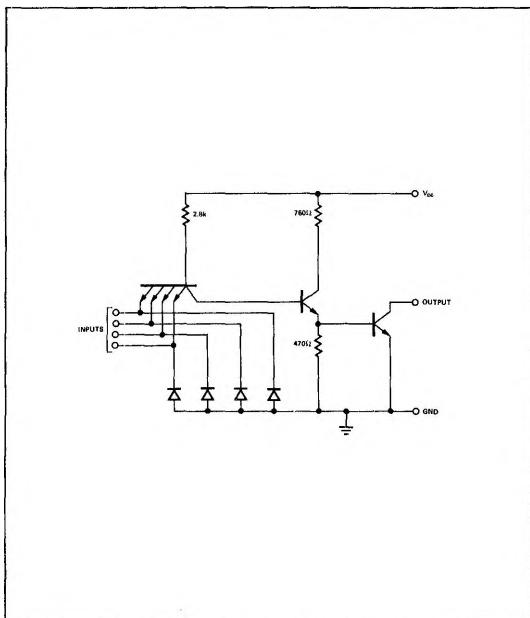
## DUAL 4-INPUT POSITIVE NAND GATE WITH OPEN COLLECTOR OUTPUT

**S54H22  
N74H22**

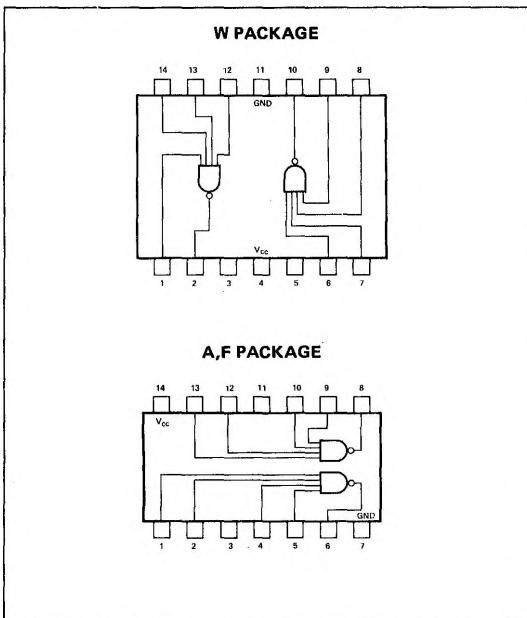
S54H22-A,F,W • N74H22-A,F

DIGITAL 54/74 TTL SERIES

### SCHEMATIC (each gate)



### PIN CONFIGURATIONS



### RECOMMENDED OPERATING CONDITIONS

	MIN	NOM	MAX	UNIT
Supply Voltage $V_{CC}$ : S54H22 Circuits	4.5	5	5.5	V
N74H22 Circuits	4.75	5	5.25	V
Normalized Fan-Out from each Output, N			10	
Operating Free-Air Temperature Range: S54H22 Circuits	-55	25	125	°C
N74H22 Circuits	0	25	70	°C

### ELECTRICAL CHARACTERISTICS (over recommended operating free-air temperature range unless otherwise noted)

PARAMETER	TEST CONDITIONS*		MIN	TYP**	MAX	UNIT
$V_{in(1)}$	Logical 1 input voltage required at all input terminals to ensure logical 0(on) level at output	$V_{CC} = \text{MIN},$		2		V
$V_{in(0)}$	Logical 0 input voltage required at any input terminal to ensure logical 1(off) level at output	$V_{CC} = \text{MIN},$			0.8	V
$I_{out(1)}$	Output reverse current	$V_{CC} = \text{MIN},$ $V_{out(1)} = 5.5V$	$V_{in} = 0.8V,$		250	$\mu\text{A}$
$V_{out(0)}$	Logical 0 output voltage (on level)	$V_{CC} = \text{MIN},$	$V_{in} = 2V,$		0.4	V
$I_{in(0)}$	Logical 0 level input current (each input)	$V_{CC} = \text{MAX},$	$V_{in} = 0.4V$		-2	$\text{mA}$
$I_{in(1)}$	Logical 1 level input current (each input)	$V_{CC} = \text{MAX},$ $V_{CC} = \text{MAX},$	$V_{in} = 2.4V$ $V_{in} = 5.5V$		50 1	$\mu\text{A}$ $\text{mA}$
$I_{CC(0)}$	Logical 0 level supply current	$V_{CC} = \text{MAX},$	$V_{in} = 4.5V$	13	20	$\text{mA}$
$I_{CC(1)}$	Logical 1 level supply current	$V_{CC} = \text{MAX},$	$V_{in} = 0$		3.4	5.0
						$\text{mA}$

**DIGITAL 54/74 TTL SERIES ■ S54H22, N74H22****SWITCHING CHARACTERISTICS,  $V_{CC} = 5V$ ,  $T_A = 26^\circ C$ ,  $N = 10$** 

PARAMETER	TEST CONDITIONS <sup>†</sup>		MIN	TYP <sup>**</sup>	MAX	UNIT
$t_{pd0}$	Propagation delay time to logical 0 level	$C_L = 25pF$ ,	$R_L = 280\Omega$	7.5	12.0	ns
$t_{pd1}$	Propagation delay time to logical 1 level	$C_L = 25pF$ ,	$R_L = 280\Omega$	10.0	15.0	ns

\* For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable device type.

\*\* All typical values are at  $V_{CC} = 5V$ ,  $T_A = 26^\circ C$ .

† Not more than one output should be shorted at a time and duration of short circuit test should not exceed 1 second.